



SLPS237B – DECEMBER 2009 – REVISED APRIL 2010

DualCool[™] N-Channel NexFET[™] Power MOSFETs

Check for Samples: CSD16325Q5C

FEATURES

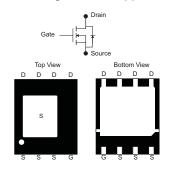
- DualCool[™] Package SON 5×6mm
- Optimized for 2-Sided Cooling
- Optimized for 5V Gate Drive
- Ultralow Q_q and Q_{qd}
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- RoHS Compliant and Halogen Free

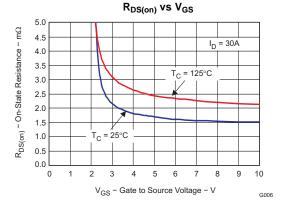
APPLICATIONS

- Point-of-Load Synchronous Buck in Networking, Telecom and Computing Systems
- Optimized for Synchronous FET Applications

DESCRIPTION

The NexFET[™] power MOSFET has been designed to minimize losses in power conversion applications and optimized for 5V gate drive applications.





PRODUCT SUMMARY

V _{DS}	Drain to Source Voltage	25	V	
Qg	Gate Charge Total (4.5V)	18		nC
Q _{gd}	Gate Charge Gate to Drain	3.5	nC	
		$V_{GS} = 3V$	2.1	mΩ
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 4.5V$	1.7	mΩ
		V _{GS} = 8V 1.5		mΩ
V _{GS(th)}	Threshold Voltage	1.1		V

ORDERING INFORMATION

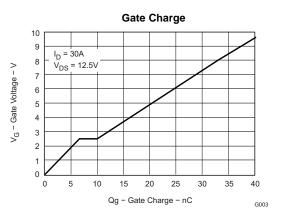
Device	Package	Media	Qty	Ship
CSD16325Q5C	SON 5×6-mm Plastic Package	13-Inch Reel	2500	Tape and Reel

ABSOLUTE MAXIMUM RATINGS

$T_A = 2$	5°C unless otherwise stated	VALUE	UNIT
V_{DS}	Drain to Source Voltage	25	V
V_{GS}	Gate to Source Voltage	+10 /8	V
	Continuous Drain Current, T _C = 25°C	100	А
ID	Continuous Drain Current ⁽¹⁾	33	А
I _{DM}	Pulsed Drain Current, $T_A = 25^{\circ}C^{(2)}$	200	А
P_D	Power Dissipation ⁽¹⁾	3.1	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to 150	°C
E _{AS}	Avalanche Energy, single pulse $I_D = 100A$, L = 0.1mH, $R_G = 25\Omega$	500	mJ

(1) Typical $R_{\theta JA}$ = 38°C/W on 1-in 2 Cu, (2-oz.) on a 0.060" thick FR4 PCB.

(2) Pulse duration $\leq 300 \mu s$, duty cycle $\leq 2\%$



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

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$(T_A = 25^{\circ}C \text{ unless otherwise stated})$

PARAMETER		TEST CONDITIONS	MIN TYP	MAX	UNIT
Static Cl	haracteristics				
BV _{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_D = 250\mu A$	25		V
I _{DSS}	Drain to Source Leakage	$V_{GS} = 0V, V_{DS} = 20V$		1	μA
I _{GSS}	Gate to Source Leakage	$V_{DS} = 0V, V_{GS} = +10/-8V$		100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.9 1.1	1.4	V
		$V_{GS} = 3V, I_D = 30A$	2.1	2.9	mΩ
R _{DS(on)}	Drain to Source On Resistance	V _{GS} = 4.5V, I _D = 30A	1.7	2.2	mΩ
		V _{GS} = 8V, I _D = 30A	1.5	2	mΩ
9 _{fs}	Transconductance	V _{DS} = 15V, I _D = 30A	159		S
Dynamic	Characteristics				
C _{iss}	Input Capacitance		3070	4000	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 12.5V,$ f = 1MHz	2190	2850	pF
C _{rss}	Reverse Transfer Capacitance		120	150	pF
R _G	Series Gate Resistance		1.6	3.2	Ω
Qg	Gate Charge Total (4.5V)		18	25	nC
Q _{gd}	Gate Charge – Gate to Drain	V _{DS} = 12.5V,	3.5		nC
Q _{gs}	Gate Charge – Gate to Source	$I_{DS} = 30A$	6.6		nC
Q _{g(th)}	Gate Charge at Vth		3.1		nC
Q _{oss}	Output Charge	$V_{DS} = 13V, V_{GS} = 0V$	43		nC
t _{d(on)}	Turn On Delay Time		10.5		ns
t _r	Rise Time	$V_{DS} = 12.5V, V_{GS} = 4.5V,$	16		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 30A$, $R_G = 2\Omega$	32		ns
t _f	Fall Time		12		ns
Diode C	haracteristics	+			
V _{SD}	Diode Forward Voltage	$I_{DS} = 30A, V_{GS} = 0V$	0.8	1	V
Q _{rr}	Reverse Recovery Charge		63		nC
t _{rr}	Reverse Recovery Time	$V_{DD} = 13V, I_F = 30A, di/dt = 300A/\mu s$	47		ns

THERMAL CHARACTERISTICS

($T_A = 25^{\circ}C$ unless otherwise stated)

	PARAMETER	MIN	TYP	MAX	UNIT
R_{\thetaJC}	Thermal Resistance Junction to Case (Top Source) ⁽¹⁾			1.4	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case (Bottom drain) ⁽¹⁾			1	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ⁽¹⁾⁽²⁾			50	°C/W

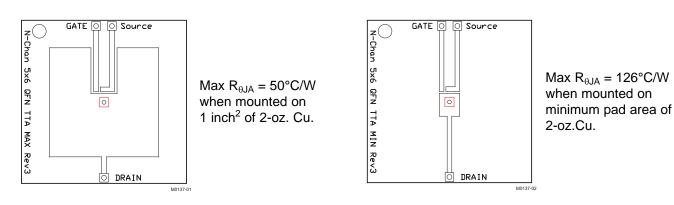
 $R_{\theta JC}$ is determined with the device mounted on a 1-inch² 2-oz. Cu pad on a 1.5 x 1.5-inch 0.060-inch thick FR4 board. $R_{\theta JC}$ is specified by design, whereas $R_{\theta CA}$ is determined by the user's board design. Device mounted on FR4 material with 1-inch² of 2-oz. Cu. (1)

(2)



CSD16325Q5C

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TYPICAL MOSFET CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

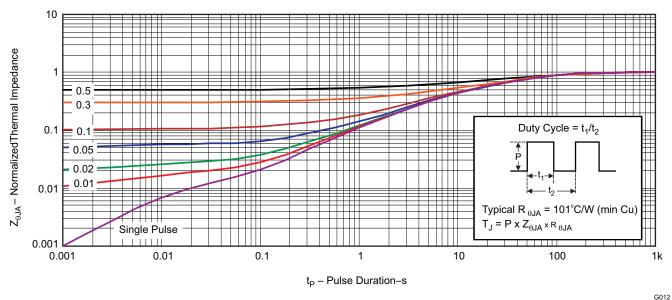


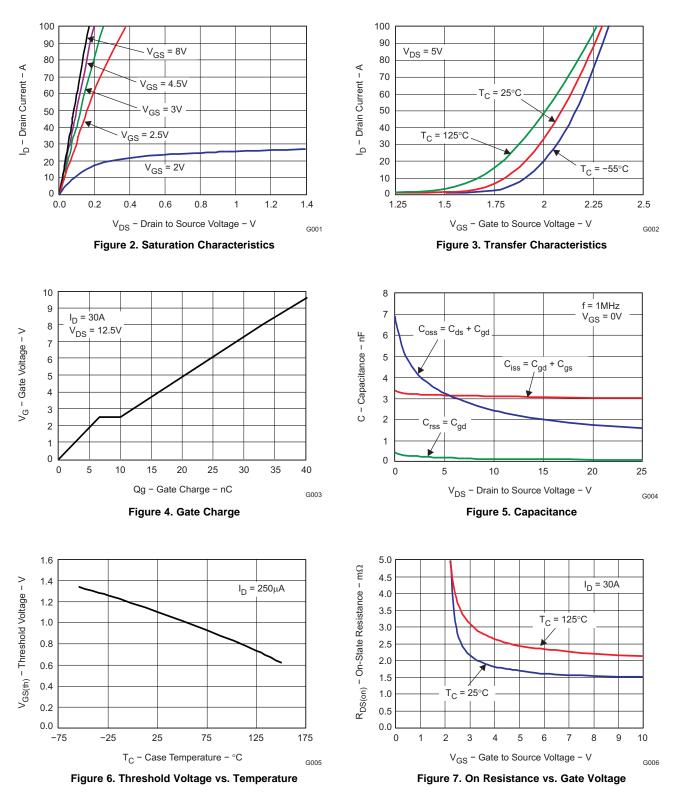
Figure 1. Transient Thermal Impedance

TEXAS INSTRUMENTS

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TYPICAL MOSFET CHARACTERISTICS (continued)

$(T_A = 25^{\circ}C \text{ unless otherwise stated})$





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TYPICAL MOSFET CHARACTERISTICS (continued)

$(T_A = 25^{\circ}C \text{ unless otherwise stated})$

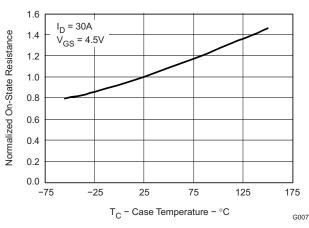


Figure 8. On Resistance vs. Temperature

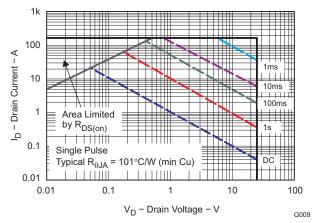


Figure 10. Maximum Safe Operating Area

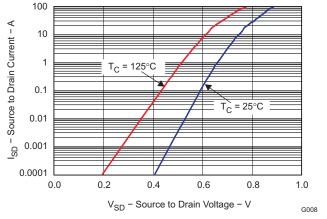


Figure 9. Typical Diode Forward Voltage

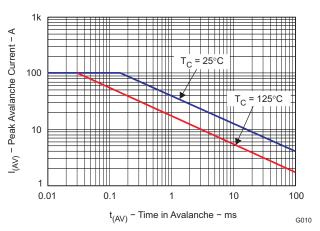
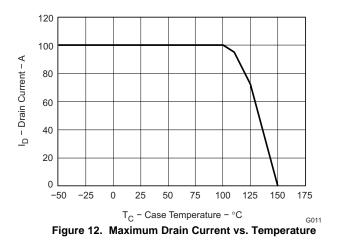


Figure 11. Single Pulse Unclamped Inductive Switching

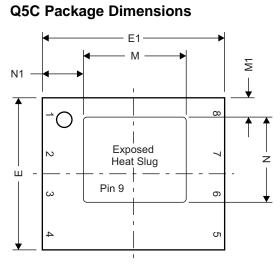


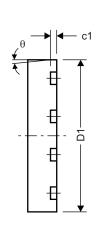
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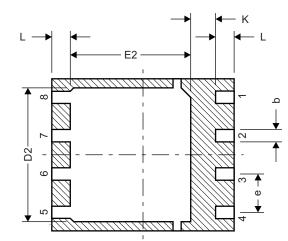


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MECHANICAL DATA



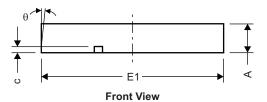




Top View

Side View

Bottom View



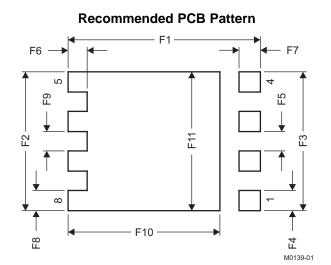
DualCool [™] Pinout					
Pin#	Label				
1, 2, 3, 9	Source				
4	Gate				
5, 6, 7, 8	Drain				

M0162-01

DIM	MILLIM	ETERS	INC	HES	
DIM	MIN	МАХ	MIN	MAX	
A	0.950	1.050	0.037	0.039	
b	0.360	0.460	0.014	0.018	
С	0.150	0.250	0.006	0.010	
c1	0.150	0.250	0.006	0.010	
D1	4.900	5.100	0.193	0.201	
D2	4.320	4.520	0.170	0.178	
E	4.900	5.100	0.193	0.201	
E1	5.900	6.100	0.232	0.240	
E2	3.920	4.12	0.154	0.162	
е	1.27	TYP	0.050		
L	0.510	0.710	0.020	0.028	
θ	-	-	-	-	
К	0.760	-	0.030	-	
М	3.260	3.460	0.128	0.136	
M1	0.520	0.720	0.020	0.028	
Ν	2.720	2.920	0.107	0.115	
N1	1.227	1.427	0.048	0.056	

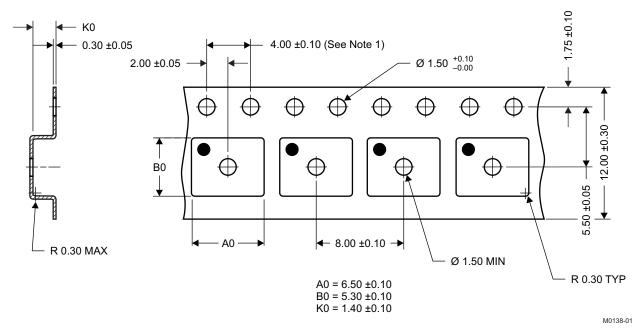


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DIM	MILLIN	IETERS	INCHES		
DIN	MIN	MAX	MIN	MAX	
F1	6.205	6.305	0.244	0.248	
F2	4.46	4.56	0.176	0.18	
F3	4.46	4.56	0.176	0.18	
F4	0.65	0.7	0.026	0.028	
F5	0.62	0.67	0.024	0.026	
F6	0.63	0.68	0.025	0.027	
F7	0.7	0.8	0.028	0.031	
F8	0.65	0.7	0.026	0.028	
F9	0.62	0.67	0.024	0.026	
F10	4.9	5	0.193	0.197	
F11	4.46	4.56	0.176	0.18	

Q5C Tape and Reel Information



Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1mm in 100mm, noncumulative over 250mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm, unless otherwise specified.
- 5. A0 and B0 measured on a plane 0.3mm above the bottom of the pocket
- 6. MSL1 260°C (IR and convection) PbF reflow compatible

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REVISION HISTORY

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



"All dimensions are nominated	ensions are nominal	
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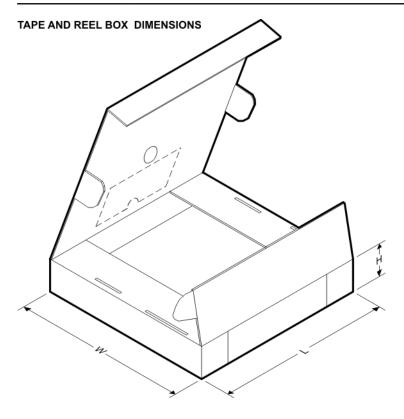
Device	•	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD16325Q5C	VSON- CLIP	DQU	8	2500	330.0	12.8	6.5	5.3	1.4	8.0	12.0	Q1

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PACKAGE MATERIALS INFORMATION

15-Apr-2014



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD16325Q5C	VSON-CLIP	DQU	8	2500	335.0	335.0	32.0

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